Phénomènes de localisation et d'universalité pour des polymères aléatoires

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3 Universality of the Pinning Model



5 Perspectives

Polymers



Interactions with

- Itself
- External environment

Depend on some parameters

Aim

- Spatial configuration
- Phase transition? Critical Points?

Intermezzo: Some Basic Probabilistic Processes

Random Walk on \mathbb{Z}^d





Self Avoiding Random Walk (SAW) on \mathbb{Z}^d

Conditioned to visit at most ones each state.



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Abstract Monomers and Abstract Polymers



Use SAW:



Abstract Polymer (*N* monomers): *N*-increments of a SAW

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Abstract Monomers and Abstract Polymers

Increment $X_i \Leftrightarrow$ a monomer



Use SAW:



Abstract Polymer (*N* monomers): *N*-increments of a SAW

SAW: challenging object!

Subclass: Directed Random Walks (Directed Polymers)



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3 Universality of the Pinning Model

Pinning Model with Heavy Tailed disorder

5 Perspectives



Pinning Model: interactions polymer ⇔ environment.



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Pinning Model: interactions polymer ⇔ environment.



Interaction with a membrane \Leftrightarrow region = straight line



Henceforth S one-dimensional.



Modify Random Walk *S*: reward/penalty whenever *S* visits 0

$$P^{\omega}_{N,\beta,\,h}(s_1,...,s_N) = \frac{1}{Z^{\omega}_{N,\beta,h}} \exp\left\{\sum_{i=1}^N g^{\omega}_i(\beta,h)\,\mathbbm{1}_{\{s_i=0\}}\right\} \cdot P(s_1,...,s_N).$$

N : polymer length

 $g_{i}^{\omega}(\beta, h) = \begin{cases} h, & \text{Homogeneous model,} \\ \beta \omega_{i} + h, & \text{Disordered model.} \quad \omega = (\omega_{i})_{i \in \mathbb{N}} \text{ disorder} \\ Z_{N,\beta,h}^{\omega} & \text{Partition Function} \end{cases}$

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Remark:

Need only $\{n : S_n = 0\}$ to define the model.

Random Walk choice

symmetric simple random walk



$$P(S_n = 0 \text{ for the first time}) \underset{n \to \infty}{\sim} \frac{c}{n^{\frac{3}{2}}}$$

Random Walk choice

symmetric simple random walk



Generalize

$$P(S_n = 0 \text{ for the first time}) \underset{n \to \infty}{\sim} \frac{c_S}{n^{1+\alpha}}, \qquad \alpha > 0.$$

Explicit examples: $\alpha \in (0, 1)$ Bessel-like Random walk.

Disorder Assumptions

Disorder ω : quenched realization of an *i.i.d.* random sequence.

 $\mathbb{E}(\omega_1) = 0$, $\mathbb{V}ar(\omega_1) = 1$, $\Lambda(\beta) = \log \mathbb{E}(e^{\beta \omega_1}) < \infty$, $\forall \beta$ small.

Examples:

- ω_1 bounded,
- ω₁ Gaussian.

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Different interesting choice:

heavy-tail case $\mathbb{P}(\omega_1 > t) \underset{t \to \infty}{\sim} c t^{-\xi}$

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Our Goal

Goal: behavior of *S* under $P^{\omega}_{\beta,h,N}$ when *N* gets large.

- N "abstract polymer" length,
- *h* Homogeneous parameter,
- β Tunes the presence of the disorder ω
- Iocalized? de-localized?
- phase transition on β , h? Critical point?

Localization/Delocalization

Free Energy

$$\begin{aligned} F^{(\alpha)}(\beta,h) &= \lim_{N \to \infty} \frac{1}{N} \mathbb{E} \left[\log Z^{\omega}_{\beta,h,N} \right] \\ \frac{\partial}{\partial h} F^{(\alpha)}(\beta,h) &= \lim_{N \to \infty} \mathbb{E} E^{\omega}_{\beta,h,N} \left(\frac{\sharp \{n \le N : S_n = 0\}}{N} \right)$$
(*)



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Analysis of the model

Goal: understand $h_c(\beta)$.

• Homogeneous model $h_c(0)$ explicit (= 0 if S is recurrent).

It provides Lower/Upper bounds

$$h_c(0) - \Lambda(\beta) \leq h_c(\beta) < h_c(0),$$

•
$$h_c(0) - \Lambda(\beta)$$
 annealed critical point.

Relevance/Irrelevance of the disorder



Aim: When $\alpha > 1/2$, asymptotics of $h_c(\beta)$ as $\beta \to 0$.

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An overview of the literature case $\alpha > 1$

Theorem (Q. Berger, F. Caravenna, J. Poisat, R. Sun, N. Zygouras, 2014)

Let $\alpha > 1$, then

$$h_c(\beta) \underset{\beta \to 0}{\sim} \tilde{c}\beta^2,$$

where \tilde{c} is explicit depending on α and c_s .

case $\alpha \in (1/2, 1)$: several authors K. S. Alexander, B. Derrida, G. Giacomin, H. Lacoin, F. L. Toninelli and N. Zygouras (2008 – 2011).

Theorem

Let $\alpha \in (1/2, 1)$, then there exist $0 < c < C < \infty$ such that

$$c\beta^{\frac{2\alpha}{2\alpha-1}} \leq h_c(\beta) \leq C\beta^{\frac{2\alpha}{2\alpha-1}},$$

for β small.



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Results

(Add some Technical assumptions on Disorder and Random Walk)

Theorem (Caravenna, Toninelli, T., 2015) Universal feature of the Free Energy

$$\mathscr{F}^{(\alpha)}(\hat{\beta},\hat{h}) = \lim_{\varepsilon \downarrow 0} \frac{F^{(\alpha)}(\hat{\beta} \varepsilon^{\alpha - \frac{1}{2}}, \hat{h} \varepsilon^{\alpha})}{\varepsilon}$$

$$\mathcal{F}^{(\alpha)}(\hat{\beta},\hat{h}) = \beta^{\frac{2}{2\alpha-1}} \mathcal{F}^{(\alpha)}\left(1,\hat{h}\beta^{-\frac{2\alpha}{2\alpha-1}}\right) \quad \Rightarrow \quad$$

$$\mathscr{H}^{(\alpha)}(\hat{\beta}) = \hat{c}\hat{\beta}^{\frac{2\alpha}{2\alpha-1}}$$

 \hat{c} non-trivial constant depending on α and c_{S} .

Theorem (Caravenna, Toninelli, T., 2015)

Universal Critical Behavior

$$h_{c}(\beta) \sim_{\beta \to 0} \hat{c} \beta^{\frac{2\alpha}{2\alpha-1}},$$

Proof - Continuum Model

•
$$\tau := \{n : S_n = 0\} \Rightarrow \varepsilon \tau \xrightarrow[\varepsilon \downarrow 0]{} \hat{\tau}$$

 Thm (C.S.Z.,15) (cond.) Pinning Model converges:

 $\beta = \hat{\beta} \varepsilon^{\alpha - \frac{1}{2}}, h = \hat{h} \varepsilon^{\alpha}$:

 t_1 t_2



Continuum ingredients:

- regenerative set $(\hat{\tau})$
- White Noise (Cont. disorder)

Problem: No Gibbs representation Wiener Chaos Expansion

Proof - Strategy: Coarse-Graining

 $N = \frac{t}{\varepsilon}. \text{ Consider } \frac{1}{N} \mathbb{E} \log Z_N$ Compare $\lim_t \lim_{\varepsilon} \& \lim_{\varepsilon} \lim_t \lim_t$



Partition function decomposition

$$Z_{1}^{c,\text{cont.}}(\tau) Z_{2}^{c}(\tau) Z_{3}^{c}(\tau) Z_{3}^{c}(\tau) Z_{4}^{c}(\tau)$$

$$Z_{i}^{c,\text{disc.}}(\tau/\varepsilon) = Z_{t/\varepsilon}^{c}(s_{i}(\varepsilon), t_{i}(\varepsilon))$$

$$Z_{i}^{c,\text{cont.}}(\hat{\tau}) = \mathscr{Z}_{t}^{c}(s_{i}, t_{i})$$

Convergence on each block



Technical difficulty

Couple together convergence of $(s_i(\varepsilon), t_i(\varepsilon))$ with $Z_{t/\varepsilon}^c(a, b)$

$$\Rightarrow \text{ Get: } \forall \eta > 0 \exists \varepsilon_0 : \forall \varepsilon < \varepsilon_0 \mathscr{F}^{(\alpha)}(\hat{\beta}, \hat{h} - \eta) \leq \varepsilon^{-1} \mathsf{F}^{(\alpha)}(\hat{\beta} \varepsilon^{\alpha - \frac{1}{2}}, \hat{h} \varepsilon^{\alpha}) \leq \mathscr{F}^{(\alpha)}(\hat{\beta}, \hat{h} + \eta)$$

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$$Z_{i}^{c,\text{cont.}}(\tau/\varepsilon) = Z_{t/\varepsilon}^{c}(\mathbf{s}_{i}(\varepsilon), t_{i}(\varepsilon))$$

$$Z_{i}^{c,\text{cont.}}(\hat{\tau}) = \mathscr{Z}_{t}^{c}(\mathbf{s}_{i}, t_{i})$$

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$$\Rightarrow \text{ Get: } \forall \eta > 0 \exists \varepsilon_0 : \forall \varepsilon < \varepsilon_0$$

$$\mathscr{F}^{(\alpha)}(\hat{\beta}, \hat{h} - \eta) \leq$$

$$\varepsilon^{-1} \mathsf{F}^{(\alpha)}(\hat{\beta} \, \varepsilon^{\alpha - \frac{1}{2}}, \, \hat{h} \, \varepsilon^{\alpha})$$

$$\leq \mathscr{F}^{(\alpha)}(\hat{\beta}, \, \hat{h} + \eta)$$

Similar to Copolymer Model

(den Hollander & Bolthausen, 1997 and Caravenna & Giacomin, 2010)





Universality of the Pinning Model



5 Perspectives



Disorder with Heavy Tail

• Disorder ω quenched realization of an i.i.d. random sequence s.t.

$$\mathbb{P}(\boldsymbol{\omega}_1 > t) \sim \mathbf{c}t^{-\boldsymbol{\xi}}, \quad t \to \infty. \quad \boldsymbol{\xi} \in (0, 1)$$

and ω_1 positive with a continuous distribution.

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and ω_1 positive with a continuous distribution.

Inspired by

A. Auffinger and O. Louidor
Directed polymers in random environment with heavy tails
B. Hambly and J. B. Martin
Heavy tails in last-passage percolation



Renewal process

Pinning model:

$$P^{\omega}_{N,\beta,\,h}(s_1,...,s_N) = \frac{1}{Z^{\omega}_{N,\beta,h}} \exp\left\{\sum_{i=1}^N (\beta\omega_i + h)\,\mathbbm{1}_{\{s_i=0\}}\right\}\,\mathbbm{1}_{\{s_N=0\}}\cdot P(s_1,...,s_N).$$

 $\mathbb{1}_{\{s_i=0\}} \Leftrightarrow \mathbb{1}_{\{i \in \tau\}}, \text{ where }$

 $\tau = \{\tau_0 = 0, \tau_1, \tau_2, \cdots\} = \{n : S_n = 0\}$ Renewal Process

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Assumptions (Renewal Process)

$$\tau = \{\tau_0 = 0, \tau_1, \tau_2, \cdots\}$$
 Renewal Process

Assumptions

$$K(n) := P(\tau_1 = n)$$
 probability on \mathbb{N} ,

$$K(n) \cong e^{-Cn^{\gamma}} \qquad \gamma \in (0, 1)$$

+ "local regularity".

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Goal

Behavior of the Pinning Model \Rightarrow

Behavior of the Renewal Process \Rightarrow consider $\tau/N \cap [0, 1]$.

- look at τ/N ∩ [0, 1] as r.v. in the space of all closed subsets of [0, 1] (which contain 0, 1).
- Equip it with Hausdorff distance:

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Hausdorff distance:
d_{H}(A, B) < \varepsilon \stackrel{\text{Def.}}{\longleftrightarrow}
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 $\forall a \in A, \exists b \in B : |a - b| < \varepsilon$ and vice-versa, interchanging *A* and *B*.



Concentration & Convergence

Take

•
$$\beta = \beta_N = \hat{\beta} N^{\gamma - \frac{1}{\xi}} \to 0 \text{ as } N \to \infty.$$

h < 0 fixed</p>

Theorem (T., 2014)

For any $\hat{\beta} > 0$ there exists a universal closed subset $\hat{j}_{\hat{\beta},\infty}^{w} \subset [0,1]$ such that

$$au/N\cap [0,1]\stackrel{\mathrm{(d)}}{ o} \hat{l}^{\mathsf{w}}_{\hat{eta},\infty}$$

in the Hausdorff metric.



Random Critical Point

Theorem (T., 2014)

• There exists $\hat{\beta}_c^{\mathsf{w}}(h)$ random variable s.t.



2 $\hat{\beta}_{c}^{\mathbf{w}}(h) > 0$ for a.e.-w and for any choice of $\boldsymbol{\xi}, \boldsymbol{\gamma} \in (0, 1)$.



Directed polymers in random environment with heavy tails

•
$$\beta = \hat{\beta}N^{1-\frac{2}{\hat{c}}} \Rightarrow \exists \hat{\gamma}_{\hat{\beta},\infty} : s_N \xrightarrow{(d)} \hat{\gamma}_{\hat{\beta},\infty}$$

• $\exists \hat{\beta}_c^w$ random critical point $\hat{\gamma}_{\hat{\beta},\infty} \hat{\beta} < \hat{\beta}_c^w$

$$\xi \in (0, 2)$$

$$P_{N,\beta}(s) = rac{e^{eta \sum_i \omega_{i,s_i}}}{Z_{N,\beta}} P(s)$$

• $\beta_c^w = 0$ if $\xi \in [1/2, 2)$ and $\beta_c^w > 0$ if $\xi \in [0, 1/3)$ Improved: $\beta_c^w > 0$ also $\xi \in [1/3, 1/2)$.





3 Universality of the Pinning Model

Pinning Model with Heavy Tailed disorder





Perspectives

- Universality for weak disorder : free energy of directed polymer in random environment.
- Structure of $\hat{l}_{\hat{\beta},\infty}$. Finite number of points?
- Renewal process with polynomial tails (and Heavy-Tailed disorder). Different limit structure?

Thanks for your attention!